

14A, 600V N-CHANNEL MOSFET

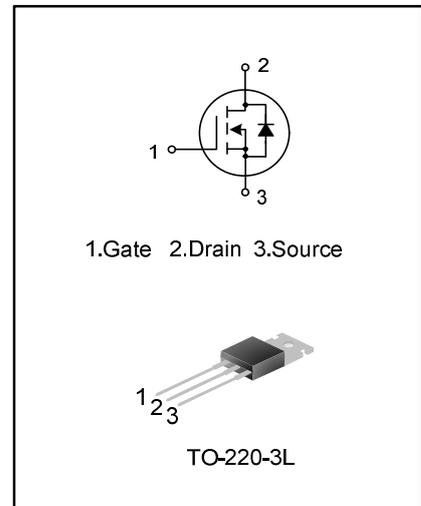
GENERAL DESCRIPTION

SVF14N60T is an N-channel enhancement mode power MOS field effect transistor which is produced using Silan proprietary F-Cell™ structure VDMOS technology. The improved process and cell structure have been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode.

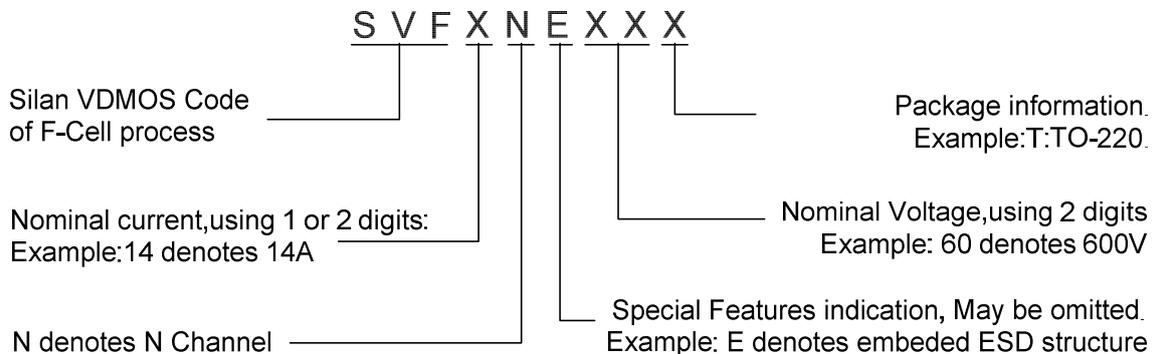
These devices are widely used in AC-DC power suppliers, DC-DC converters and H-bridge PWM motor drivers.

FEATURES

- ◆ 14A,600V, $R_{DS(on)(typ)}=0.54\Omega@V_{GS}=10V$
- ◆ Low gate charge
- ◆ Low Crss
- ◆ Fast switching
- ◆ Improved dv/dt capability



NOMENCLATURE



ORDERING INFORMATION

Part No.	Package	Marking	Hazardous Substance Control	Packing
SVF14N60T	TO-220-3L	SVF14N60T	Pb free	Tube

ABSOLUTE MAXIMUM RATINGS (T_C=25°C unless otherwise noted)

Characteristics		Symbol	Ratings	Unit
Drain-Source Voltage		V _{DS}	600	V
Gate-Source Voltage		V _{GS}	±30	V
Drain Current	T _C =25°C	I _D	14	A
	T _C =100°C		8.9	
Drain Current Pulsed		I _{DM}	56	A
Power Dissipation(T _C =25°C) -Derate above 25°C		P _D	176	W
			1.41	W/°C
Single Pulsed Avalanche Energy (Note 1)		E _{AS}	850	mJ
Operation Junction Temperature Range		T _J	-55~+150	°C
Storage Temperature Range		T _{stg}	-55~+150	°C

THERMAL CHARACTERISTICS

Characteristics	Symbol	Ratings	Unit
Thermal Resistance, Junction-to-Case	R _{θJC}	0.71	°C/W
Thermal Resistance, Junction-to-Ambient	R _{θJA}	62.5	°C/W

ELECTRICAL CHARACTERISTICS (T_C=25°C unless otherwise noted)

Characteristics	Symbol	Test conditions	Min.	Typ.	Max.	Unit
Drain -Source Breakdown Voltage	B _{VDS}	V _{GS} =0V, I _D =250μA	600	--	--	V
Drain-Source Leakage Current	I _{DSS}	V _{DS} =600V, V _{GS} =0V	--	--	1.0	μA
Gate-Source Leakage Current	I _{GSS}	V _{GS} =±30V, V _{DS} =0V	--	--	±100	nA
Gate Threshold Voltage	V _{GS(th)}	V _{GS} = V _{DS} , I _D =250μA	2.0	--	4.0	V
Static Drain- Source On State Resistance	R _{DS(on)}	V _{GS} =10V, I _D =7.0A	--	0.54	0.64	Ω
Input Capacitance	C _{iss}	V _{DS} =25V, V _{GS} =0V, f=1.0MHz	--	1540	--	pF
Output Capacitance	C _{oss}		--	175	--	
Reverse Transfer Capacitance	C _{rss}		--	6.0	--	
Turn-on Delay Time	t _{d(on)}	V _{DD} =300V, I _D =14A, R _G =25Ω (Note 2, 3)	--	25.8	--	ns
Turn-on Rise Time	t _r		--	45.0	--	
Turn-off Delay Time	t _{d(off)}		--	80.8	--	
Turn-off Fall Time	t _f		--	41.6	--	
Total Gate Charge	Q _g	V _{DS} =480V, I _D =14A, V _{GS} =10V (Note2, 3)	--	30.8	--	nC
Gate-Source Charge	Q _{gs}		--	8.74	--	
Gate-Drain Charge	Q _{gd}		--	11.4	--	

SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS

Characteristics	Symbol	Test conditions	Min.	Typ.	Max.	Unit
Continuous Source Current	I_S	Integral Reverse p-n Junction	--	--	14	A
Pulsed Source Current	I_{SM}	Diode in the MOSFET	--	--	56	
Diode Forward Voltage	V_{SD}	$I_S=14A, V_{GS}=0V$	--	--	1.3	V
Reverse Recovery Time	T_{rr}	$I_S=14A, V_{GS}=0V,$	--	590	--	ns
Reverse Recovery Charge	Q_{rr}	$di_F/dt=100A/\mu S$ (Note 2)	--	6.3	--	μC

Notes:

1. $L=30mH, I_{AS}=7.0A, V_{DD}=100V, R_G=25\Omega,$ starting $T_J=25^\circ C;$
2. Pulse Test: Pulse width $\leq 300\mu s,$ Duty cycles $\leq 2\%;$
3. Essentially independent of operating temperature.

TYPICAL CHARACTERISTICS

Figure 1. On-Region Characteristics

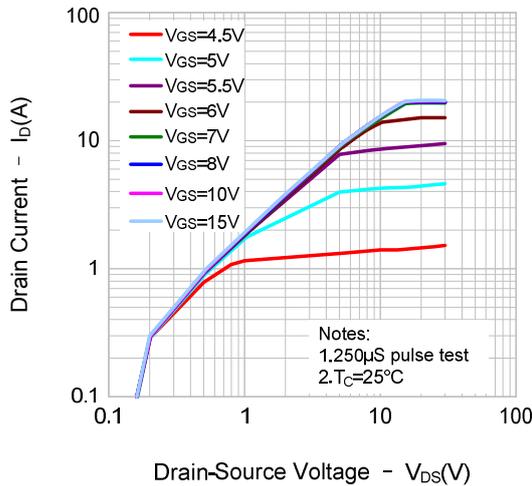


Figure 2. Transfer Characteristics

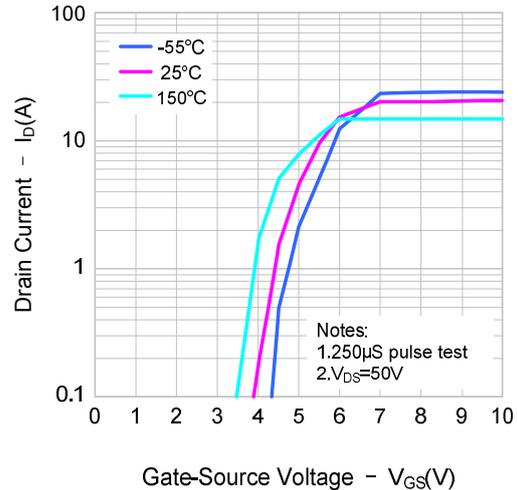


Figure 3. On-Resistance Variation vs. Drain Current

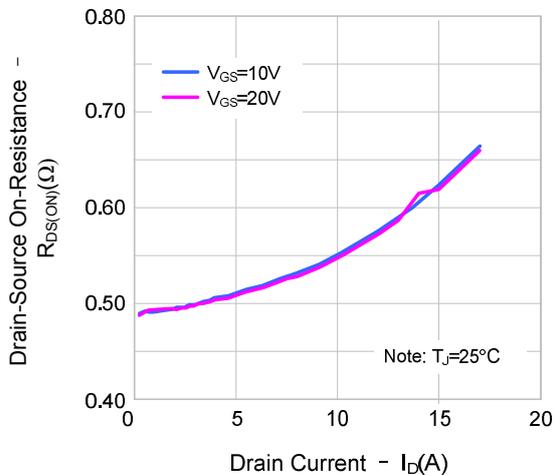
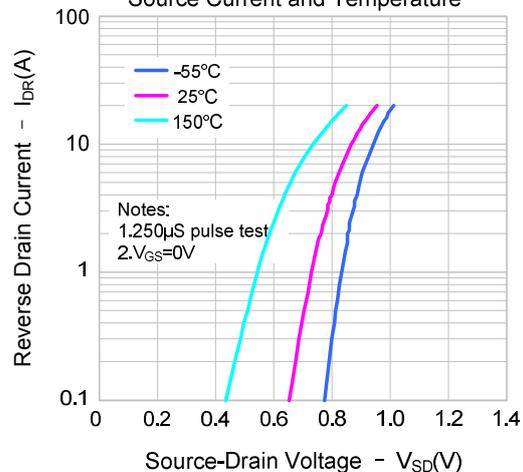
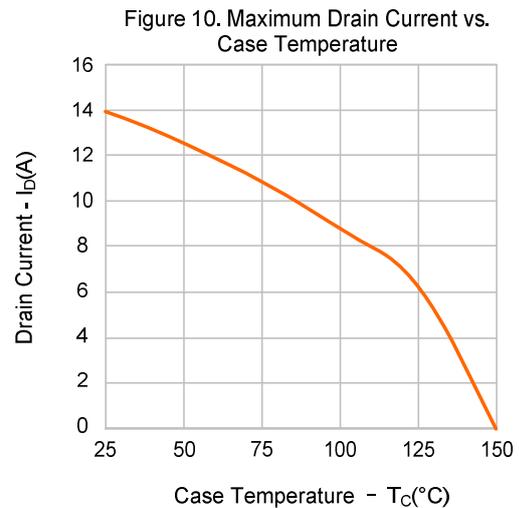
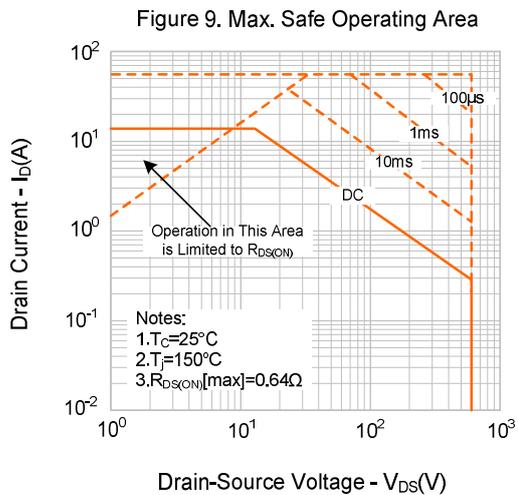
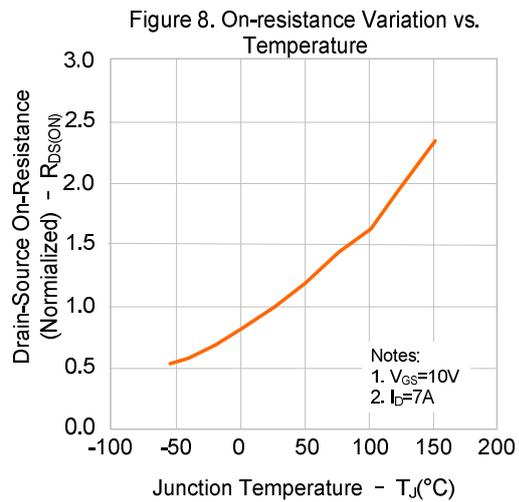
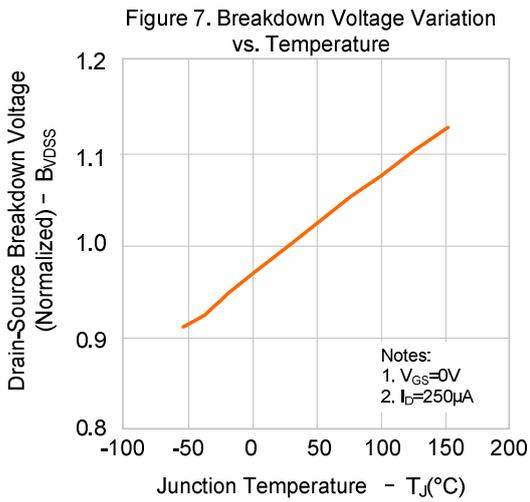
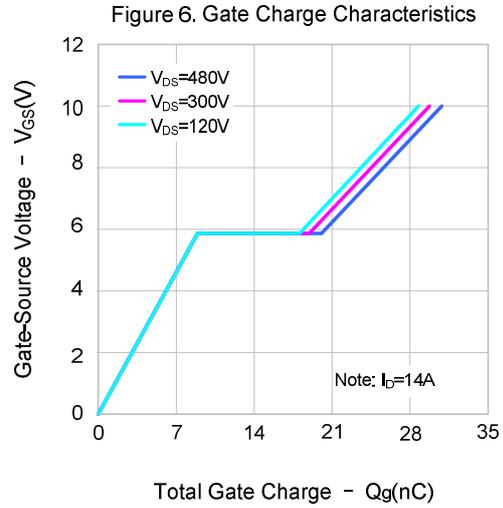
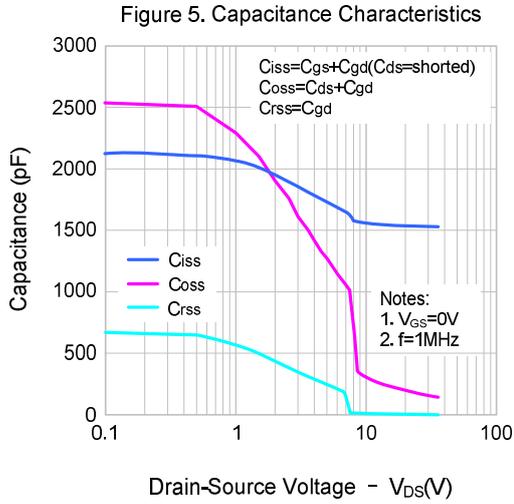


Figure 4. Body Diode Forward Voltage vs. Source Current and Temperature

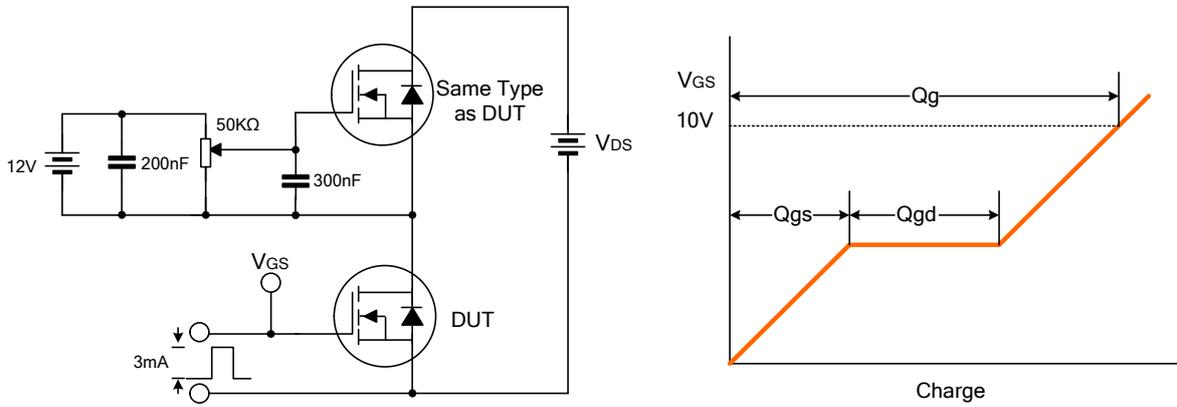


TYPICAL CHARACTERISTICS(continued)

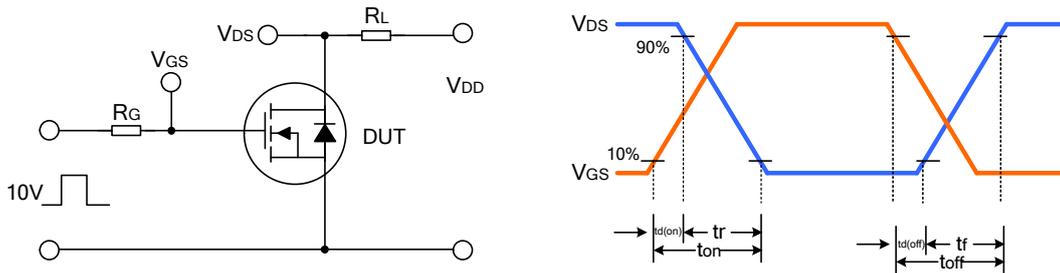


TYPICAL TEST CIRCUIT

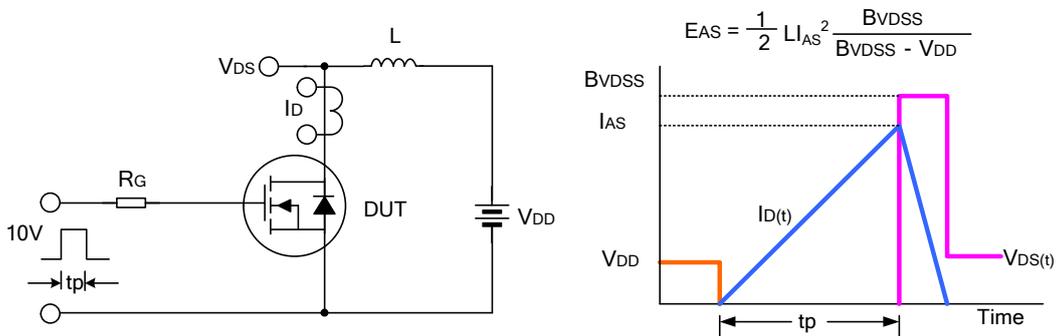
Gate Charge Test Circuit & Waveform



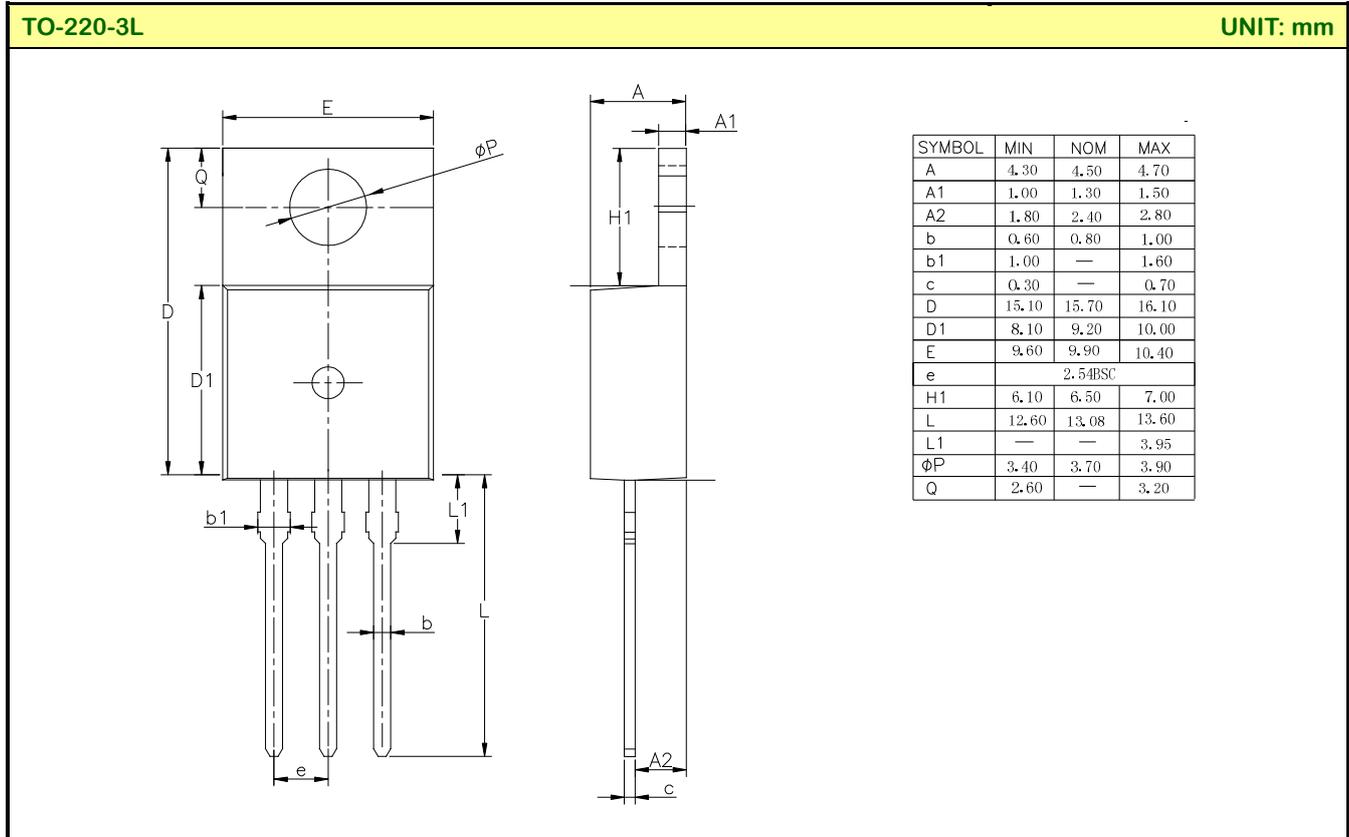
Resistive Switching Test Circuit & Waveform



Unclamped Inductive Switching Test Circuit & Waveform



PACKAGE OUTLINE



Disclaimer :

- Silan reserves the right to make changes to the information herein for the improvement of the design and performance without prior notice! Customers should obtain the latest relevant information before placing orders and should verify that such information is complete and current.
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Part No.:	SVF14N60T	Document Type:	Datasheet
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Rev.:	1.2	Author:	Yin Zi
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Revision History:

1. Modify the Typical Characteristics

Rev.:	1.1	Author:	Yin Zi
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Revision History:

1. Modify the package information of TO-220-3L

Rev.:	1.0	Author:	Yin Zi
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Revision History:

1. First release
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